

All-digital Hybrid-control Buck Converter for Integrated Voltage Regulator Applications

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Abstract—As power-dissipation remains a roadblock to maintaining growth in computational performance, the trend toward increasingly aggressive reliance on Dynamic Voltage and Frequency Scaling (DVFS) by power management systems, and Integrated Voltage Regulation (IVR) in particular, will continue. As voltage domains continue to shrink, and an increasing number of Voltage Regulators (VRs) are employed within a System-on-Chip (SoC), all-digital buck converters will become increasingly important from a scalability, portability, and system-methodology perspective. In addition to the existing challenges facing VR Modules, IVRs face additional efficiency and transient response challenges. In this paper, we propose a voltage-reference-free all-digital hybrid-control buck converter addressing these challenges through novel techniques for accurate digital derivative measurement for *PID* control, and fast, all-digital non-linear control for minimizing voltage droop. Simulations in 65nm CMOS demonstrate an 86% efficient, stable operation with fast transient response. A single-phase implementation using package mounted inductor and filter capacitor models achieves a 25mV droop for a 5A load current ramp at 500mA/ns.

I. INTRODUCTION

Energy-efficiency continues to limit continued performance growth in modern computing systems. Although designers aggressively employ a variety of techniques to yield efficiency improvements, DVFS remains the most effective method to be employed thus far, and trends indicate continued aggressive DVFS use in the increasingly heterogeneous and multi-core systems of the future. Much work has been done on IVR systems [1]–[4]. Multiple power domains with faster transient response provide enhanced spatial and temporal control of individual voltage domains, enabling greatly enhanced DVFS implementations. As future microprocessors are posed to have hundreds of voltage domains [5], made possible only by integrated regulation, current IVR designs face several challenges including (1) the increasing difficulty and scalability of traditional analog IVR implementations (2) Degraded compatibility of IVR designs within, and portability across largely digital modules within the SoC, and (3) the need for fast-response IVR implementations due to the reduced available decoupling capacitance (decap) per voltage domain.

A basic digital buck converter architecture is outlined in Figure I. The sensed supply voltage is compared to a reference V_{ref} . The resulting error is converted into a digital code, and processed by a digital compensator (often a PID, or lead/lag implementation), whose output drives a Digital Pulse Width Modulator (DPWM) module which drives the bridge with the appropriate duty-cycle to maintain regulation.

Digital buck converter implementations are an attractive, scalable solution, offering (1) Improved portability across designs. (2) Improved scalability across technology generations in

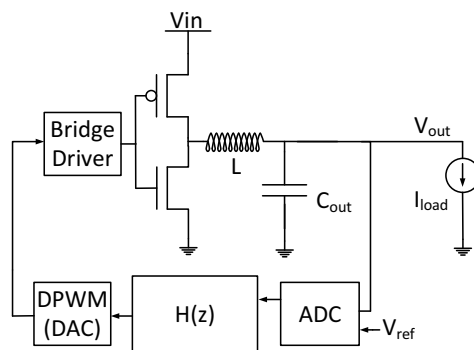


Fig. 1. Conventional ADC-based Digital Buck Converter

contrast with prevalent analog IVR design techniques. (3) Fully synthesizable control implementations, readily compatible with modern SoC design flows. (4) Reduced susceptibility to process variation, requiring less post-fabrication trimming and calibration, reducing complexity and test-time. Consequently, digital IVR implementations are expected to play an important role the number of on-chip voltage domains continues to grow.

Several key challenges face state-of-the-art digital IVR control implementations. Reduced available per-domain filter capacitance requires even faster transient load response. Modern Advanced Configuration and Power Interface (ACPI) systems requiring a supply-voltage resolution of 6.25mV, or equivalently 8-bits of ADC resolution. Suppressing quantization error for stable control requires even higher resolution in the ADC, and consequently in the DPWMs [6], increasing power and complexity. Ripple-based techniques including time-optimal [7] and hysteresis-based architectures [8] have been proposed in the literature. Although well-suited to IVR applications due to their superior transient response, hysteretic control has not been widely adopted due the need for careful design to avoid noise and instability challenges [9]. Furthermore, these designs have not been demonstrated using all-digital circuits.

In this paper, we propose an all-digital hybrid-control voltage regulator suitable for IVR applications. The contributions of this work are as follows. (1) We propose an all-digital, voltage-reference free IVR design that effectively tracks the critical path of DVFS-enabled digital systems across its operating supply voltage range, avoiding margins due to temperature variation and regulator offsets. (2) A novel time-based discrete difference technique that efficiently enables the accurate measurement of the output voltage derivative used in *PID* control is proposed. (3) We propose the first all-digital hybrid-control implementation for IVRs driving digital systems.

Simulations in an industrial 65nm process technology demon-

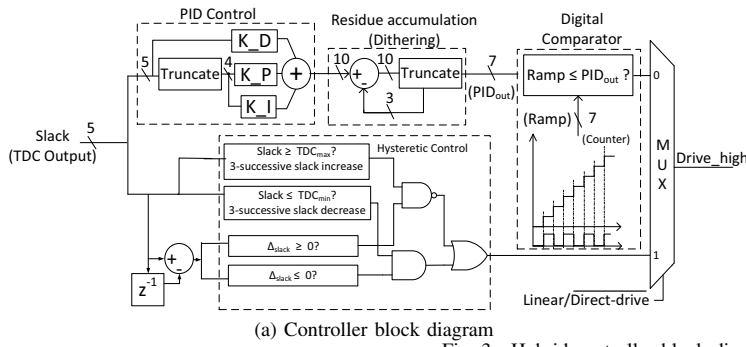


Fig. 3. Hybrid-controller block diagram and operation

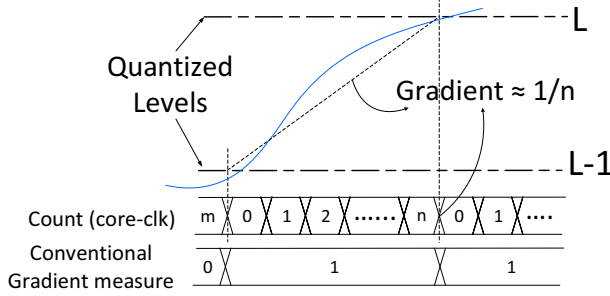
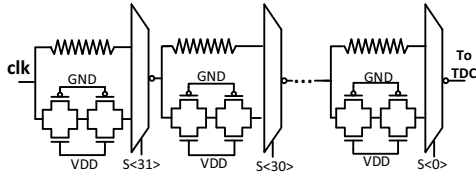


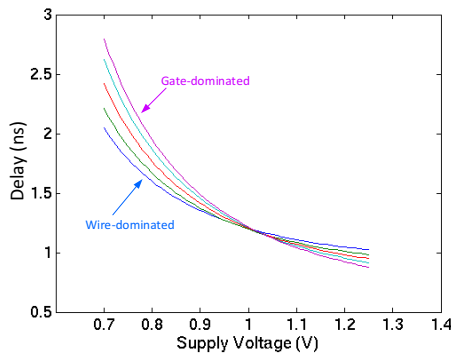
Fig. 4. Calculation of the discrete-time derivative of the error signal

avoiding limit cycles) further improves the effective resolution of the PWM by a factor of 8.

IV. CPM AND TDC DESIGN



(a) CPM simplified schematic. Delay elements within the chain are independently programmed to exhibit wire-dominated, or gate-dominated delay



(b) Simulation results of CPM delay over a range of V_{out} values. Selecting a mix of gate and wire-dominated delay cells provides a range of voltage-delay sensitivities

Fig. 5. CPM design

Figure 5 shows a simplified schematic of the CPM design, and simulation results demonstrating its ability to model a range

of voltage-delay sensitivities in the system critical path. Canary circuits [10] have previously been used to model a limited set of critical paths decided upon at design-time. Such an approach is suited to a specific system block and is not readily portable to multiple voltage domains. In the proposed approach, two “basis” delay cells are employed – wire-dominated, and gate-dominated, corresponding to the lowest and highest possible delay-voltage sensitivities respectively. A convex combination of these two cells within the CPM chain will span the range of possible delay-voltage sensitivities as seen in Figure 5b, allowing the proposed construction to be portable across multiple designs. The TDC in the proposed architecture employs a vernier delay line [11] to achieve a CPM-TDC voltage (worst-case) resolution of 6mV at 1.2V.

V. SIMULATION RESULTS

TABLE I
PARAMETERS USED FOR SIMULATION EXPERIMENTS

Parameter	Quantity
V_{in}	2.0V
V_{out}	0.8V – 1.2V
I_{Load} (max)	6A
C_{pkg}, ESR	10 μ F, 2m Ω [12]
L, R_L	13nH, 40m Ω [13]
Switching Frequency	15.6MHz
CPM-TDC resolution	6mV
DPWM resolution (w/ dithering)	7 (10)

The hybrid-control architecture was evaluated in an industrial 65nm process technology through simulation analysis of a one-phase implementation assuming the use of package mounted inductors and decoupling capacitors. Circuit/system parameters used in our evaluation are outlined in Table I. package parasitics are included in the analysis. The bridge offers significant switching capacitance due to its size and use of metal and vias to reduce conduction losses. Therefore, wiring parasitics associated with the bridge and the pre-drivers were also included in the simulation. With the exception of the TDC and CPM, the all-digital controller was synthesized and constructed using auto-place-and-route tools prior to netlist extraction. Efficiency estimates of the converter includes the dissipation of all constituent blocks.

Figure 6 shows the simulated efficiency achieved by the proposed all-digital buck converter over a load current range of 1.5A to 4.5A at supply voltages of 0.8V, 1V and 1.2V. The

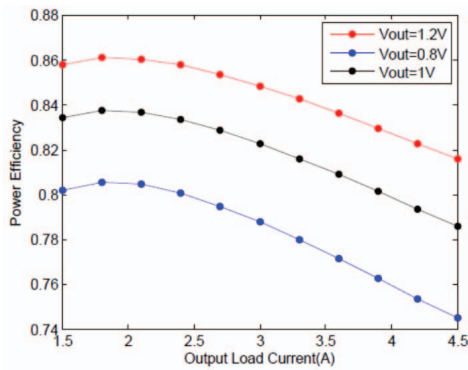
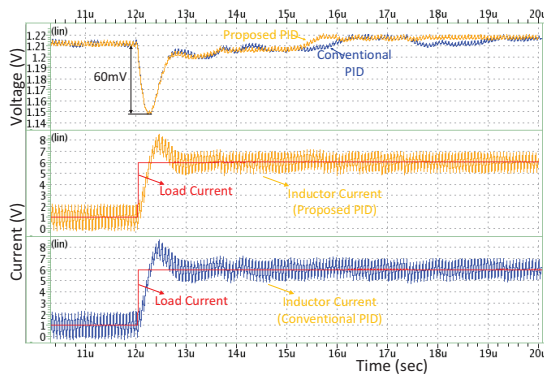
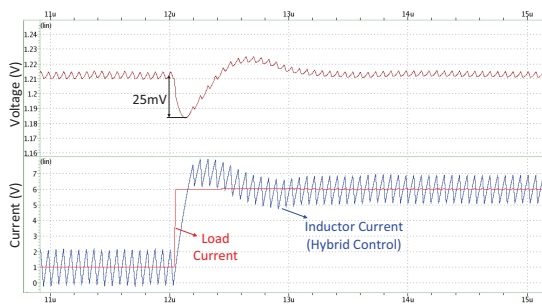


Fig. 6. Simulated efficiency of the hybrid-control converter

converter efficiency is dominated by the I^2R losses in the air-core inductor, a problem effectively addressed by increasing the phase count of the converter (outside the scope of this work). The existing simulation configuration achieves a peak efficiency of 86% at 2A of current load. Implemented with 211 standard-cells, the controller dissipates 5mW, accounting for approximately 0.5% of the power losses in the system at 2A.



(a) Conventional PID controller and proposed PID control with enhanced derivative measurement (direct-drive disabled). Inaccuracy in difference calculation causes a less stable restoration of the supply voltage



(b) Hybrid-control provides a stable response with minimal droop voltage

Fig. 7. Simulated transient response of V_{out} (conventional and proposed) due to a 10ns-5A current load ramp

Figure 7 shows the impact of the proposed architecture on transient step response. To examine effectiveness of the improved derivative calculation in the proposed architecture in linear feedback-mode, we evaluated current step response with direct-drive disabled. Figure 7a illustrates the voltage and cur-

rent response of the architecture in linear-feedback mode, along with the step response of a conventional PID controller. The peak droop in both implementations is observed to be 60mV. With the hybrid controller enabled, a stable response with a peak droop of 25mV as shown in Figure 7b. As V_{out} transitions to V_{SS} , and the positive slack margin falls below TDC_{min} , the hybrid-controller turns on the bridge to *continuously* increase the inductor current to meet the load current demand, during which time V_{out} continues to fall. When the inductor current exceeds the load current and V_{out} begins to transition upward, the high resolution TDC detects the transition and the control-law selection logic transitions the system into linear feedback mode, allowing for a gradual, near-seamless settling of the voltage. Notably, the proposed digital architecture enables the buck converter to respond with minimal time (accounting for non-zero granularity of digital control) – The actual regulator droop voltages vary based on the choice of inductors and filter capacitance.

VI. CONCLUSION

In this paper, we present a novel, all-digital hybrid-control buck converter architecture for IVR applications. The proposed architecture operates in linear-feedback mode in steady-state, and relies on a direct-drive approach to provide fast transient response. The proposed control law ensures smooth transition between the two modes. We also propose a novel approach to enabling enhanced voltage-difference measurement to allow for more stable PID response. By operating in linear mode under steady state, the proposed approach also readily translates to multi-phase operation. Simulation experiments indicate a 25mV peak droop at the output voltage of the converter in response to a 5A current ramp at 500mA/ns. The converter achieves a peak efficiency of 86% at 2A.

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